

承認書 SPECIFICATION FOR APPROVAL





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OneWave Electronic Co., Ltd.

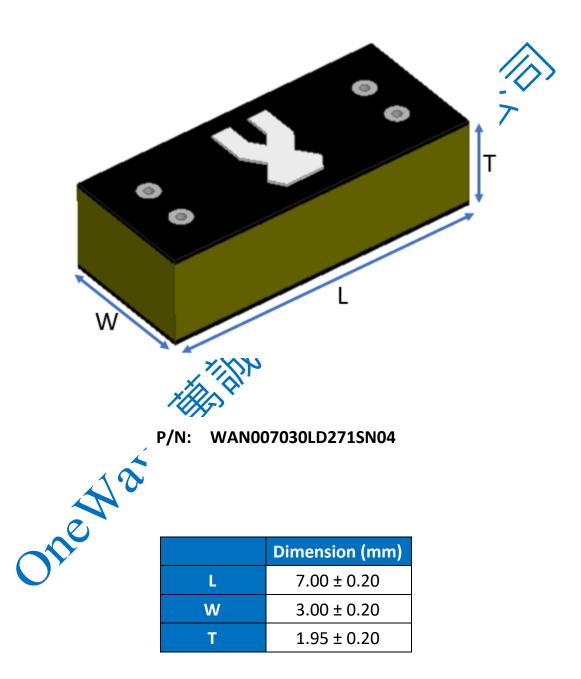
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7030 Chip antenna

For WI-FI 6E / 7 Applications



Part Number Information

WAN	<u>00</u>	<u>7030</u>	L	D27	<u>1S</u>	<u>N</u>	<u>04</u>
Α		В	С	D		Ε	F

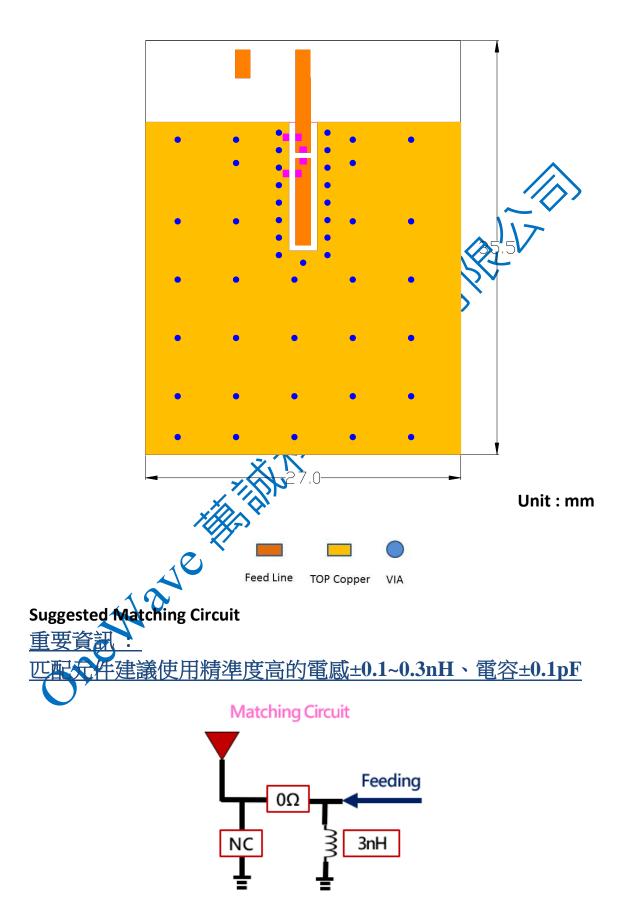
Α	Product Series	Antenna			
В	Dimension L x W	7.0X3.0mm (+-0.2mm)			
С	Material	High K material			
D	Working Frequency 2.4 ~ 2.5GHz + 5.15~5.85GH				
		5.925~7.125GHz	<i>))</i>		
E	Feeding mode	Monopole & Single Feeding			
F	Antenna type	type Type = 04			
ectrical Specification					
Specification					

1. Electrical Specification

Specification				
Part Number	WAN007030LD271SN04			
Central Frequency	× 2450 / 5500 / 6525	MHz		
Bandwidth	100 / 800 / 1200 (Min.)	MHz		
Return Loss	-10 (Max)	dB		
Peak Gain	2.95 / 5.40 / 5.35	dBi		
Impedance	50	Ohm		
Operating Temperature	-40~+110	°C		
Maximum Power	4	W		
Resistance to Soldering Heats	10 (@ 260 ℃)	sec.		
Polarization	Linear			
Azimuth Beamwidth	Omni-directional			
Termination	Cu / Sn (Leadless)			

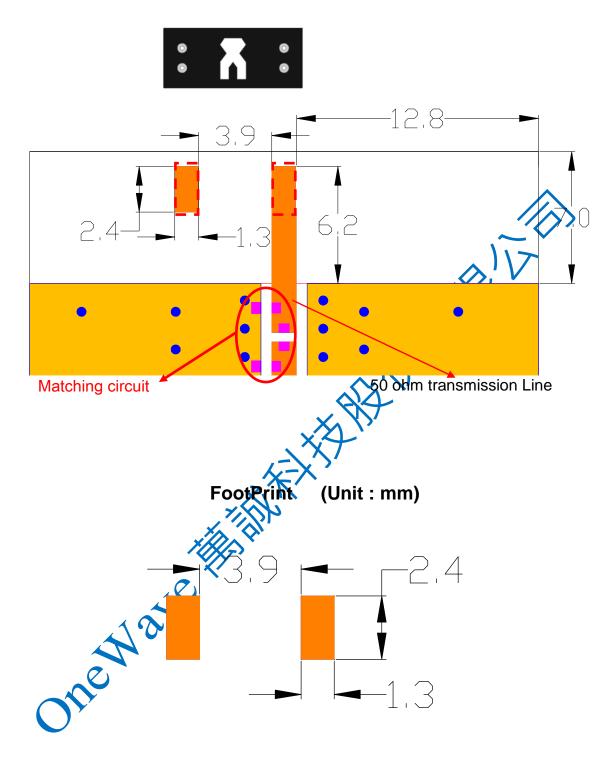
Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

2. Recommended PCB Pattern Evaluation Board Dimension



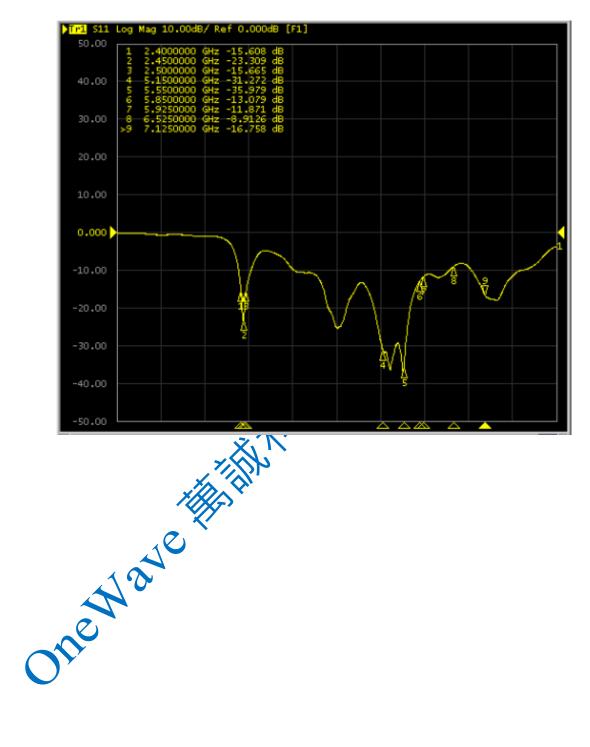


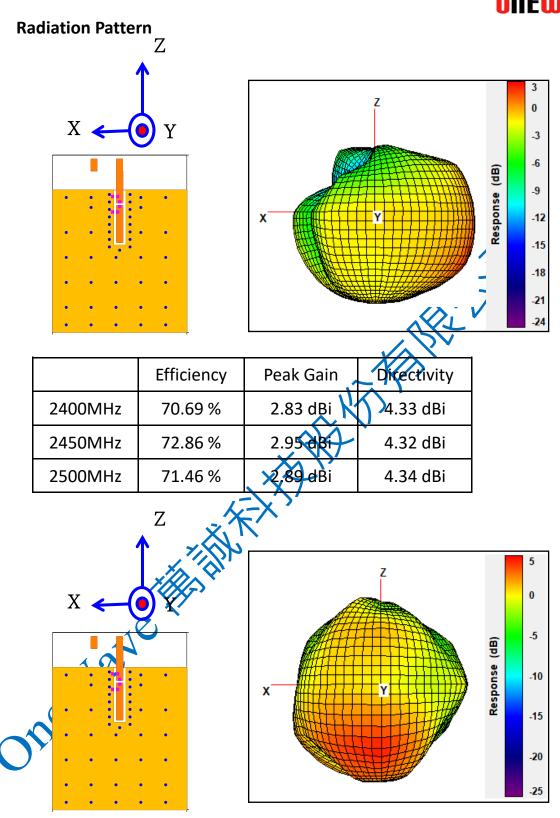
Layout Dimensions in Clearance area(Size=27.0*7.0mm)



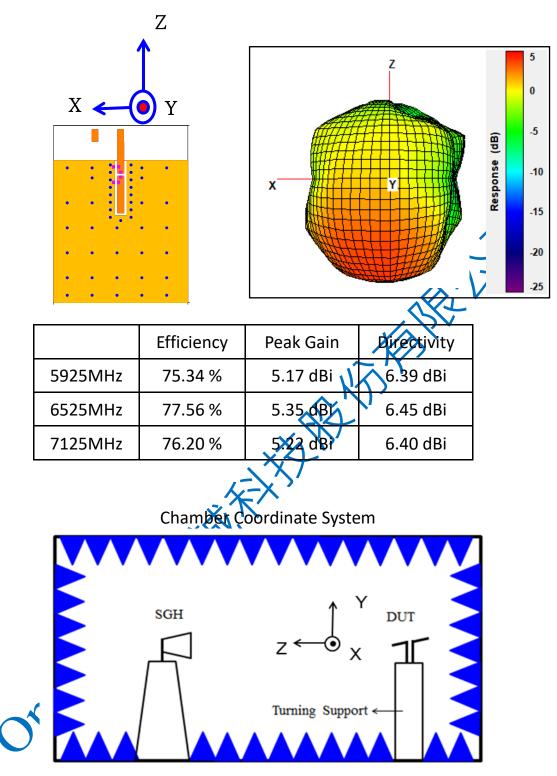
3. Measurement Results

Return Loss





	Efficiency	Peak Gain	Directivity
5150MHz	75.83 %	5.28 dBi	6.48 dBi
5500MHz	78.80 %	5.40 dBi	6.43 dBi
5850MHz	76.44 %	5.34 dBi	6.50 dBi





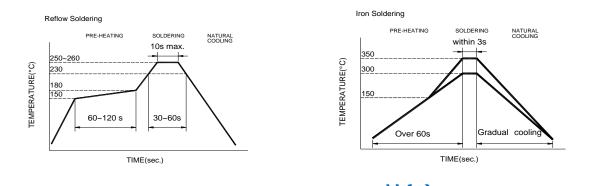
4.Reliability and Test Condictions

ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	1. Wetting shall exceed 90% coverage			
Soluerability	2. No visible mechanical damage	Pre-heating temperature: 150° C/60sec. Solder temperature: $230\pm 5^{\circ}$ C		
	Ŭ	Duration:4±1sec.		
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5		
	230°C4±1 sec.	Flux for lead free: rosin		
	150°C			
	60sec			
Solder heat	4. No visible mechanical demons			
Resistance	 No visible mechanical damage Central Freq. change :within ± 6% 	Pre-heating temperature:150℃/60sec.		
Resistance		Solder temperature:260±5°C		
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5		
	260°C 10±0.5 sec.	Flux for lead free: rosin		
	150°C	$\wedge' \vee$		
	60sec			
Component	1. No visible mechanical damage	The device should be reflow		
Adhesion		soldered (280 \pm 5°C for 10sec.) to a tinned		
(Push test)		copper substrate A dynometer force		
		gauge should be applied the side of the		
		component. The device must with-ST-F		
		0.5 Kg without failure of the termination attached to component.		
Component	1. No visible mechanical damage	Insert 10cm wire into the remaining open		
Adhesion		eye bend ,the ends of even wire lengths		
(Pull test)		upward and wind together.		
		Terminal shall not be remarkably		
	X, N	damaged.		
Thermal shock	4. Na visible mechanical demons	+110°C=>30±3min		
Thermal Shock	1. No visible mechanical damage	-40°C => 30±3min		
	2. Central Freq. change :within ±6%	Test cycle:10 cycles		
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal		
	1 +110±5℃ 30±3	condition for 2~3 hours before		
	2 Room Within	measuring.		
	Z Temperature 3sec	medsuning.		
	3 -40±2°C 30±3			
	4 Room Within			
	4 Temperature 3sec			
	0			
Resistance to	1. No visible mechanical damage	Temperature: +110±5℃		
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		
Resistance to	1. No visible mechanical damage	Temperature:-40±5°C		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature		The chip shall be stabilized at normal		
	3. No disconnection or short circuit.	condition for 2~3 hours before		
		measuring.		
Humidity	1. No visible mechanical damage	Temperature: 40±2°C		
	_	Humidity: 90% to 95% RH		
	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		

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5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



Recommended temperature profiles for rection soldering in Figure 1.

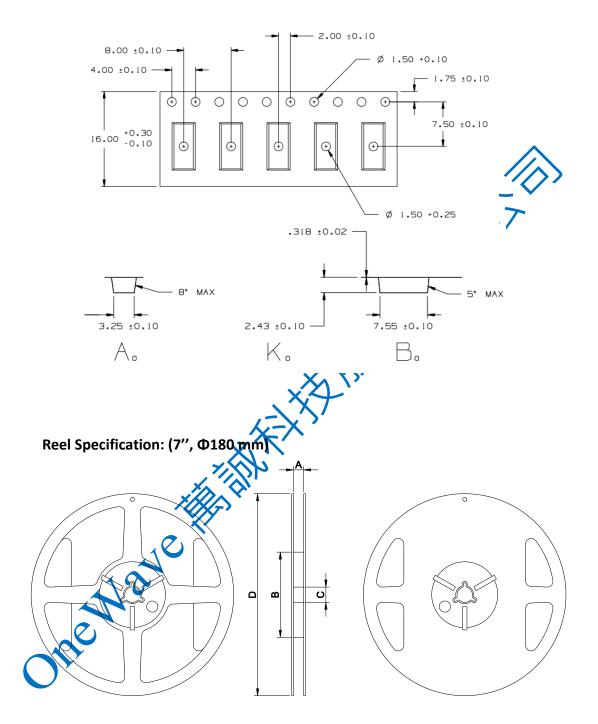
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precaptions are recommended.

- Preheat circuit and products to $150^\circ C$
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- Omm tip diameter (max)
- Limit soldering time to 3 sec.



6.Packaging Information

• Tape Specification:



7" x 16 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
16	16±1.0	60±2	13.5±0.5	178±2	2000

7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40° C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

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- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.